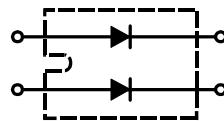


# HiPerFRED™ Epitaxial Diode with soft recovery

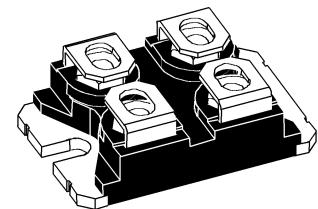
## Preliminary Data

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
400	400	DSEP 2x 31-04A



I<sub>FAV</sub> = 2x 30 A  
V<sub>RRM</sub> = 400 V  
t<sub>rr</sub> = 30 ns

miniBLOC, SOT-227 B



Symbol	Conditions	Maximum Ratings	
I <sub>FRMS</sub>		100	A
I <sub>FAVM</sub>	T <sub>C</sub> = 105°C; rectangular, d = 0.5	30	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t <sub>p</sub> = 10 ms (50 Hz), sine	tbd	A
E <sub>AS</sub>	T <sub>VJ</sub> = 25°C; non-repetitive I <sub>AS</sub> = tbd A; L = tbd μH	tbd	mJ
I <sub>AR</sub>	V <sub>A</sub> = 1.5·V <sub>R</sub> typ.; f = 10 kHz; repetitive	tbd	A
T <sub>VJ</sub>		-40...+150	°C
T <sub>VJM</sub>		150	°C
T <sub>stg</sub>		-40...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C	100	W
V <sub>ISOL</sub>	50/60 Hz, RMS I <sub>ISOL</sub> ≤ 1 mA	2500	V~
M <sub>d</sub>	mounting torque (M4) terminal connection torque (M4)	1.1-1.5/9-13 1.1-1.5/9-13	Nm/lb.in. Nm/lb.in.
Weight	typical	30	g

Symbol	Conditions	Characteristic Values	
		typ.	max.
I <sub>R</sub> ①	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub> T <sub>VJ</sub> = 150°C V <sub>R</sub> = V <sub>RRM</sub>	0.25 1.0	mA mA
V <sub>F</sub> ②	I <sub>F</sub> = 30 A; T <sub>VJ</sub> = 125°C T <sub>VJ</sub> = 25°C	1.15 1.45	V V
R <sub>thJC</sub> R <sub>thCH</sub>		0.1	1.15 K/W K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/μs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	30	ns
I <sub>RM</sub>	V <sub>R</sub> = 100 V; I <sub>F</sub> = 50 A; -di <sub>F</sub> /dt = 100 A/μs T <sub>VJ</sub> = 100°C	6.8	A

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %  
② Pulse Width = 300 μs, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

## Features

- International standard package miniBLOC
- Isolation voltage 2500 V~
- UL registered E 72873
- 2 independent FRED in 1 package
- Planar passivated chips
- Very short recovery time
- Extremely low switching losses
- Low I<sub>RM</sub>-values
- Soft recovery behaviour

## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I<sub>RM</sub> reduces:
  - Power dissipation within the diode
  - Turn-on loss in the commuting switch

Dimensions see outlines.pdf

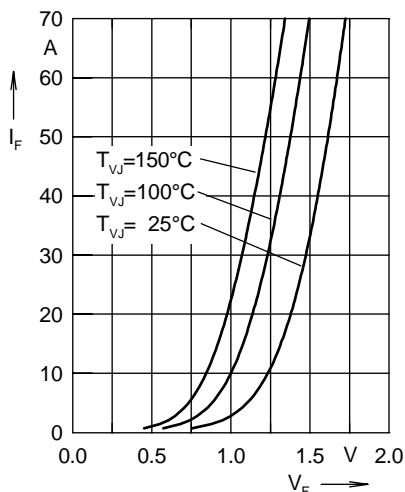


Fig. 1 Forward current  $I_F$  versus  $V_F$

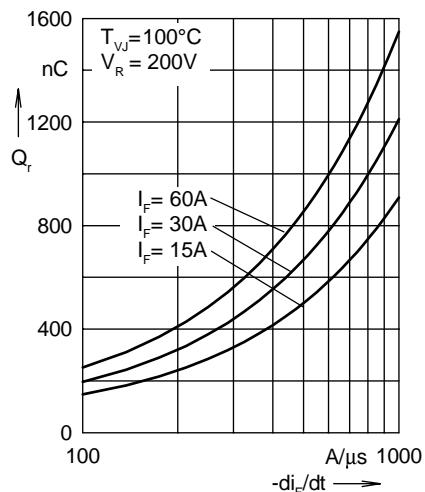


Fig. 2 Reverse recovery charge  $Q_r$  versus  $-di_F/dt$

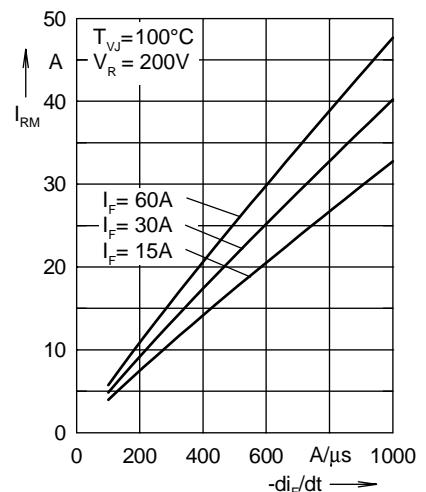


Fig. 3 Peak reverse current  $I_{RM}$  versus  $-di_F/dt$

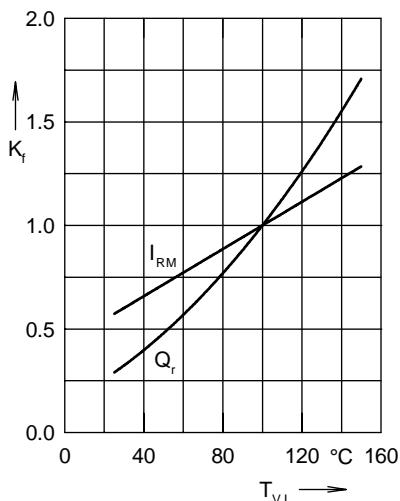


Fig. 4 Dynamic parameters  $Q_r$ ,  $I_{RM}$  versus  $T_{VJ}$

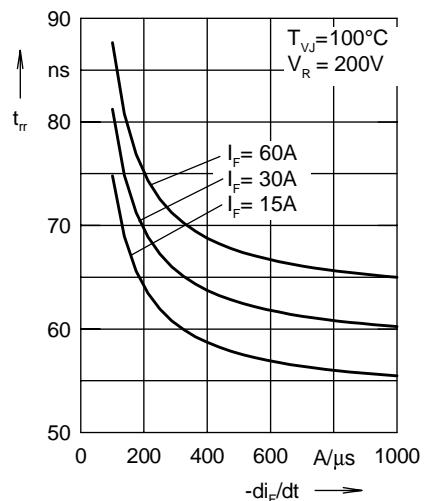


Fig. 5 Recovery time  $t_{rr}$  versus  $-di_F/dt$

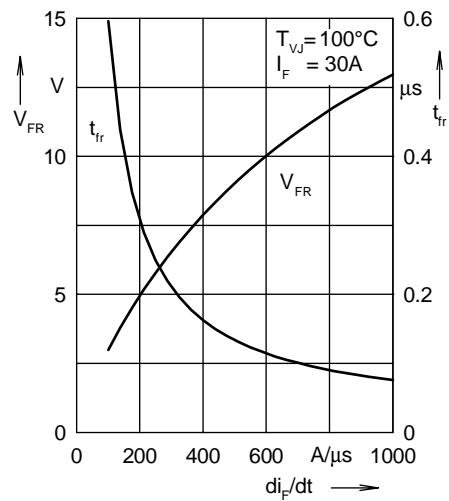


Fig. 6 Peak forward voltage  $V_{FR}$  and  $t_{rr}$  versus  $di_F/dt$

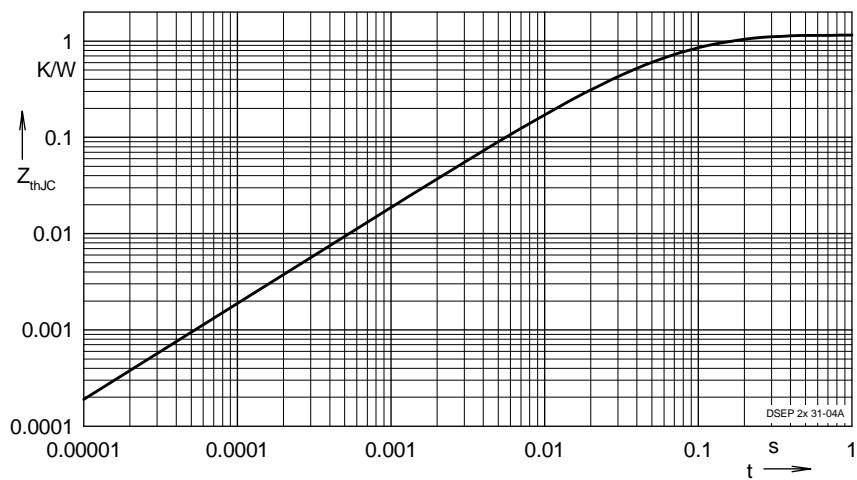


Fig. 7 Transient thermal resistance junction to case

NOTE: Fig. 2 to Fig. 6 shows typical values

© 2000 IXYS All rights reserved

Constants for  $Z_{thJC}$  calculation:

i	$R_{thi}$ (K/W)	$t_i$ (s)
1	0.436	0.0055
2	0.482	0.0092
3	0.117	0.0007
4	0.115	0.0418